

Notice of References Cited	Application/Control No. 10/750,465	Applicant(s)/Patent Under Reexamination CHEN, NIEN-TSU	
	Examiner Mike Fatahiyar	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,824,354	07-1974	Anderson et al.	200/1R
*	B	US-6,525,714 B1	02-2003	Varga et al.	345/164
*	C	US-4,247,845	01-1981	Schmidt et al.	341/35
*	D	US-4,970,512	11-1990	Wood, Lawson A.	341/35
*	E	US-3,005,055	10-1961	MATTKE CHARLES F	341/184
*	F	US-7,146,005 B1	12-2006	Anft et al.	379/433.06
*	G	US-4,246,452	01-1981	Chandler, David P.	200/5A
*	H	US-7,042,445 B2	05-2006	Hara et al.	345/184
*	I	US-4,443,670	04-1984	Nakamura et al.	200/11DA
*	J	US-6,710,562 B2	03-2004	Kalb et al.	318/434
*	K	US-6,686,911 B1	02-2004	Levin et al.	345/184
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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